



Sheet 1

LIST OF ART CITED BY APPLICANT

(Use several sheets if necessary)

Atty Docket No.	01-016	Serial No.	09/878,642
Applicant John Albert Hockman			
Filing Date 6/11/2001		Group 1731	

U.S. Patent Documents

EXAMINER INITIALS		DOCUMENT NUMBER	DATE	NAME	Class/Subclass	FILING DATE IF APPROPRIATE
<i>MPK</i>	AA	3,381,064	4/ 1968	Yamaguchi		
<i>MPK</i>	AB	3,458,331	7/ 1969	Kroyer		
<i>MPK</i>	AC	3,520,705	7/ 1970	Fumiko Shido et al.		
<i>MPK</i>	AD	3,802,901	4/ 1974	Robertson, et al.		
<i>MPK</i>	AE	3,817,776	6/ 1974	M. Gringas		
<i>MPK</i>	AF	3,875,288	4/ 1975	Hoffman et al.		
<i>MPK</i>	AG	3,883,364	5/ 1975	Robertson, et al.		
<i>MPK</i>	AH	3,926,647	12/ 1975	Wuhrer		
<i>MPK</i>	AI	3,941,574	3/ 1976	Melkonian et al.		
<i>MPK</i>	AJ	3,956,446	5/ 1976	Eirich et al.		
<i>MPK</i>	AK	3,967,943	7/ 1976	Seeley		

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	Class/Subclass	Translation Yes/No
<i>MPK</i>	AL	JP 53-139621	12/78	Japan		yes
<i>MPK</i>	AM	JP 55 149122	5/79	Japan		yes
<i>MPK</i>	AN	SU 644 731	1/79	Russia		yes
<i>MPK</i>	AO	SU 823 285	4/81	Russia		yes
<i>MPK</i>	AP	SU 981 217	12/82	Russia		yes
<i>MPK</i>	AQ	SU 340 257	5/83	Russia		yes

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

<i>MPK</i>	AR	"Glass", Kirk - Ohmer, Encyclopedia of Chemical Technology, 4 th Edition 1994, vol. 12, pp. 555-564, 593-601.
<i>MPK</i>	AS	Mirkovich, V.V.; "Utilization of Diopside in the Manufacture of Glass," Mines Branch Technical Bulletin TB 192; Dept. of Energy, Mines and Resources (Ottawa, Canada 1974).
	AT	Mirkovich, V.V. et al; "Utilization of Diopside in the Manufacture of Glass (Part II)," Journal of the Canadian Ceramic Society; Volume 44, pp. 43-47; (1975).

Examiner

Date Considered

*EXAMINER: initial reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Sheet 2

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U.S. Patent Documents

EXAMINER INITIALS		DOCUMENT NUMBER	DATE	NAME	Class/Subclass	FILING DATE IF APPROPRIATE
<i>WPK</i>	AA	3,969,100	7/1976	Kuna et al.		
<i>WPK</i>	AB	4,026,691	5/1977	Lovett et al.		
<i>WPK</i>	AC	4,023,976	5/1977	Bauer, et al.		
<i>WPK</i>	AD	4,028,131	6/1977	Pons		
<i>WPK</i>	AE	4,110,097	8/1978	Chevallier et al.		
<i>WPK</i>	AF	4,252,754	2/1981	Nakaguchi		
<i>WPK</i>	AG	4,474,594	10/1984	Lazet		
<i>WPK</i>	AH	4,519,814	5/1985	Demarest, Jr.		
<i>WPK</i>	AI	4,612,292	9/1986	Richard		
<i>WPK</i>	AJ	4,634,461	1/1987	Demarest, Jr. et al.		
<i>WPK</i>	AK	4,920,080	4/1990	Demarest, Jr.		
<i>WPK</i>	AL	5,004,706	4/1991	Dickinson		

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	Class/Subclass	Translation Yes/No
<i>WPK</i>	AM	JP 59 64563	4/84	Japan		yes
<i>WPK</i>	AN	JP 2 141454	5/90	Japan		yes
<i>WPK</i>	AO	42 28 500	9/92	Germany		yes
<i>WPK</i>	AP	JP 10 291852	11/98	Japan		yes
	AQ	JP 09-285849		Japan		no
<i>WPK</i>	AR	141 105	4/1980	German		yes

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

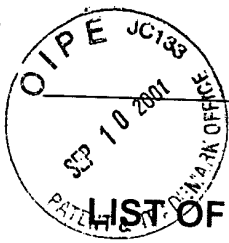
	AS	
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Examiner <i>Michael Chelvin</i>	Date Considered 6/27/02
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<i>MPK</i>	AA	5,100,840	1992	Urabe et al.	<i>II</i>	
<i>MPK</i>	AB	5,422,320	1995	Adams, Jr. et al.	<i>II</i>	
<i>MPK</i>	AC	5,900,052	1999	Nakajima et al.	<i>II</i>	
<i>MPK</i>	AD	6,287,378	2001	Fairchild et al.	<i>II</i>	
<i>MPK</i>	AE	6,271,159	2001	Fairchild et al.	<i>II</i>	
<i>MPK</i>	AF	6,287,997	2001	Fairchild et al.	<i>II</i>	
<i>MPK</i>	AG	6,211,103 B1	2001	Tomaino et al.	<i>II</i>	
	AH					
	AI					
	AJ					
	AK					

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	AQ				

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	AR	
	AS	
	AT	<i>NONE</i>

Examiner *Michael Colman*

Date Considered *6/27/02*

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